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October 2015

#### **FDMD8530**

# Dual N-Channel PowerTrench<sup>®</sup> MOSFET Q1: 30 V, 201 A, 1.25 m $\Omega$ Q2: 30 V, 201 A, 1.25 m $\Omega$

#### **Features**

Q1: N-Channel

- Max  $r_{DS(on)}$  = 1.25 m $\Omega$  at  $V_{GS}$  = 10 V,  $I_D$  = 35 A
- Max  $r_{DS(on)}$  = 1.5 m $\Omega$  at  $V_{GS}$  = 4.5 V,  $I_D$  = 32 A

Q2: N-Channel

- Max  $r_{DS(on)}$  = 1.25 m $\Omega$  at  $V_{GS}$  = 10 V,  $I_D$  = 35 A
- Max  $r_{DS(on)}$  = 1.5 m $\Omega$  at  $V_{GS}$  = 4.5 V,  $I_D$  = 32 A
- Ideal for Flexible Layout in Primary Side of Bridge Topology
- 100% UIL Tested
- Kelvin High Side MOSFET Drive Pin-out Capability
- RoHS Compliant

#### **General Description**

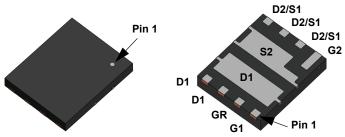
This device includes two 30V N-Channel MOSFETs in a dual power (5 mm X 6 mm) package. HS source and LS drain internally connected for half/full bridge, low source inductance package, low  $r_{DS(on)}/Qg$  FOM silicon.

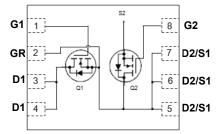
#### **Applications**

- POL Synchronous Dual
- One Phase Motor Half Bridge
- Half/Full Bridge Secondary Synchronous Rectification









Power 5 x 6

#### MOSFET Maximum Ratings T<sub>A</sub> = 25 °C unless otherwise noted.

Symbol	Parame	eter		Q1	Q2	Units
$V_{DS}$	Drain to Source Voltage			30	30	V
$V_{GS}$	Gate to Source Voltage			±20	±20	V
	Drain Current -Continuous	T <sub>C</sub> = 25 °C	(Note 5)	201	201	
	-Continuous	T <sub>C</sub> = 100 °C	(Note 5)	127	127	1
ID	Drain Current -Continuous	T <sub>A</sub> = 25 °C		35 <sup>1a</sup>	35 <sup>1b</sup>	A
	-Pulsed		(Note 4)	1047	1047	
E <sub>AS</sub>	Single Pulse Avalanche Energy		(Note 3)	661	661	mJ
Б	Power Dissipation	T <sub>C</sub> = 25 °C		78	78	١٨/
$P_{D}$	Power Dissipation	T <sub>A</sub> = 25 °C		2.2 <sup>1a</sup>	2.2 <sup>1b</sup>	W
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Tempera	ture Range		-55 to	+150	°C

#### **Thermal Characteristics**

$R_{ heta JC}$	Thermal Resistance, Junction-to-Case	1.6	1.6	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	55 <sup>1a</sup>	55 <sup>1b</sup>	C/VV

#### **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMD8530	FDMD8530	Power 5 x 6	13 "	12 mm	3000 units

### **Electrical Characteristics** $T_J = 25$ °C unless otherwise noted.

Symbol	Parameter	Parameter Test Conditions		Min.	Тур.	Max.	Units
Off Cha	racteristics						
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	I <sub>D</sub> = 250 μA, V <sub>GS</sub> = 0 V	Q1 Q2	30 30			٧
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, referenced to 25 °C	Q1 Q2		20 20		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 0 V	Q1 Q2			1 1	μА
I <sub>GSS</sub>	Gate to Source Leakage Current	V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V	Q1 Q2			±100 ±100	nA

#### On Characteristics

V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	Q1 Q2	1.0 1.0	1.5 1.5	3.0 3.0	٧
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, referenced to 25 °C	Q1 Q2		-5 -5		mV/°C
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 35 A			0.77	1.25	
	Static Drain to Source On Resistance	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 32 A	Q1		0.96	1.5	mΩ
_		$V_{GS}$ = 10 V, $I_{D}$ = 35 A, $T_{J}$ = 125 °C			1.1	1.8	
r <sub>DS(on)</sub>		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 35 A			0.77	1.25	
		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 32 A	Q2		0.96	1.5	
		$V_{GS}$ = 10 V, $I_{D}$ = 35 A, $T_{J}$ = 125 °C			1.1	1.8	
9 <sub>FS</sub>	Forward Transconductance	V <sub>DD</sub> = 5 V, I <sub>D</sub> = 35 A	Q1 Q2		259 259		S

#### **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance		Q1 Q2		7425 7425	10395 10395	pF
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V f = 1 MHz	Q1 Q2		2190 2190	3070 3070	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		Q1 Q2		220 220	310 310	pF
R <sub>g</sub>	Gate Resistance		Q1 Q2	0.1 0.1	1.9 1.9	3.8 3.8	Ω

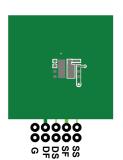
#### **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time			Q1 Q2	14 14	25 25	ns
t <sub>r</sub>	Rise Time	V - 45 V I - 25	^	Q1 Q2	13 13	24 24	ns
			$V_{DD} = 15 \text{ V, } I_{D} = 35 \text{ A}$ $V_{GS} = 10 \text{ V, } R_{GEN} = 6 \Omega$	Q1	71	114	
$t_{d(off)}$	Turn-Off Delay Time	VGS - 10 V, NGEN		Q2	71	114	ns
	Fall Times		Q1	21	34		
t <sub>f</sub>	Fall Time		Q2	21	34	ns	
0	Total Gate Charge	\/ = 0\/ to 10\/		Q1	106	149	nC
$Q_{g(TOT)}$	Total Gate Charge	$V_{GS} = 0 V \text{ to } 10 V$		Q2	106	149	IIC
0	Total Gate Charge	\/ = 0 \/ to 4 5 \/		Q1	50	70	nC
$Q_{g(TOT)}$	Total Gate Charge	$V_{GS} = 0 V \text{ to } 4.5 V$	\/ - 15 \/	Q2	50	70	110
0	Gate to Source Charge		<sup>⊥</sup> V <sub>DD</sub> = 15 V, I <sub>D</sub> =35 A	Q1	16		nC
$Q_{gs}$	Gale to Source Charge		ID -00 X	Q2	16		IIC
0	Gate to Drain "Miller" Charge			Q1	13		nC
$Q_{gd}$	Gate to Drain Willer Charge			Q2	13		IIC

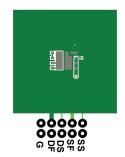
#### Electrical Characteristics T<sub>J</sub> = 25 °C unless otherwise noted.

Symbol	Parameter	Test Conditions		Type	Min	Тур	Max	Units
Drain-S	ource Diode Characteristics							
$V_{SD}$	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 35 \text{ A}$ (N	Note 2)	Q1 Q2		8.0 8.0	1.3 1.3	V
V <sub>SD</sub>	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 2 \text{ A}$ (N	Note 2)	Q1 Q2		0.7 0.7	1.2 1.2	V
t <sub>rr</sub>	Reverse Recovery Time	1 - 25 4 - 400 4/ -		Q1 Q2		54 54	87 87	ns
Q <sub>rr</sub>	Reverse Recovery Charge	I <sub>F</sub> = 35 A, di/dt = 100 A/μs		Q1 Q2		39 39	63 63	nC

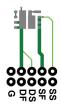
1.  $R_{\theta JA}$  is determined with the device mounted on a 1 in 2 pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material.  $R_{\theta CA}$  is determined by the user's board design.



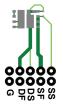
a. 55 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



b. 55 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



c. 155 °C/W when mounted on a minimum pad of 2 oz copper



d. 155 °C/W when mounted on a minimum pad of 2 oz copper

- 2. Pulse Test: Pulse Width < 300  $\mu$ s, Duty cycle < 2.0 %.
- 3. Q1:  $E_{AS}$  of 661 mJ is based on starting  $T_J = 25\,^{\circ}\text{C}$ ,  $L = 3\,\text{mH}$ ,  $I_{AS} = 21\,\text{A}$ ,  $V_{DD} = 30\,\text{V}$ ,  $V_{GS} = 10\,\text{V}$ . 100% tested at  $L = 0.1\,\text{mH}$ ,  $I_{AS} = 65\,\text{A}$ . Q2:  $E_{AS}$  of 661 mJ is based on starting  $T_J = 25\,^{\circ}\text{C}$ ,  $L = 3\,\text{mH}$ ,  $I_{AS} = 21\,\text{A}$ ,  $V_{DD} = 30\,\text{V}$ ,  $V_{GS} = 10\,\text{V}$ . 100% tested at  $L = 0.1\,\text{mH}$ ,  $I_{AS} = 65\,\text{A}$ .
- 4. Pulsed Id please refer to Fig 11 SOA graph for more details.
- 5. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

#### Typical Characteristics (Q1 N-Channel) T<sub>J</sub> = 25°C unless otherwise noted.

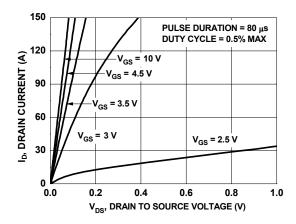


Figure 1. On Region Characteristics

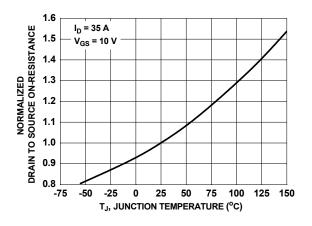


Figure 3. Normalized On Resistance vs. Junction Temperature

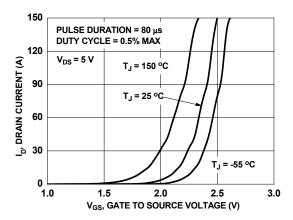


Figure 5. Transfer Characteristics

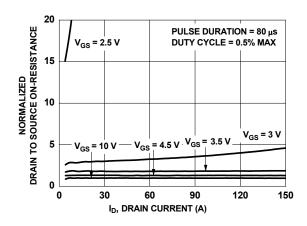


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

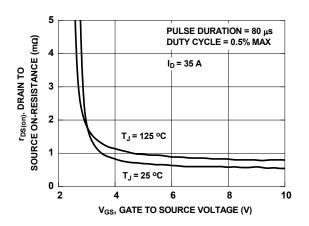


Figure 4. On-Resistance vs. Gate to Source Voltage

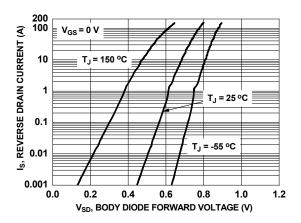


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

#### Typical Characteristics (Q1 N-Channel) T<sub>J</sub> = 25°C unless otherwise noted.

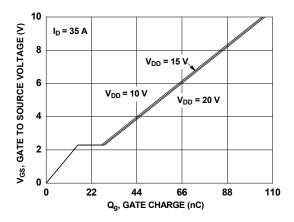


Figure 7. Gate Charge Characteristics

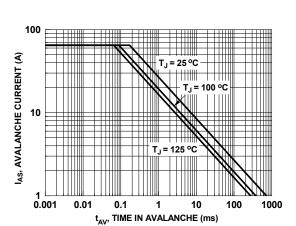


Figure 9. Unclamped Inductive Switching Capability

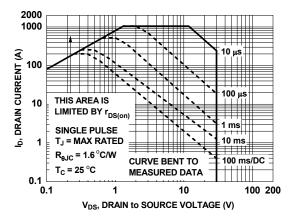


Figure 11. Forward Bias Safe Operating Area

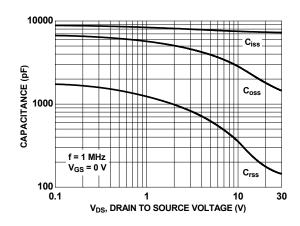


Figure 8. Capacitance vs. Drain to Source Voltage

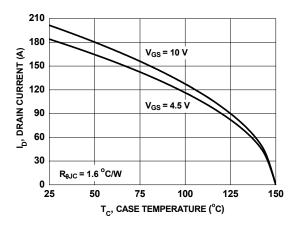


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

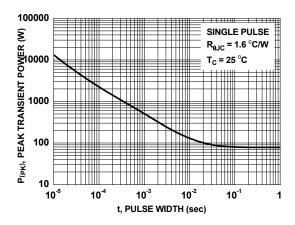


Figure 12. Single Pulse Maximum Power Dissipation

#### Typical Characteristics (Q1 N-Channel) T<sub>J</sub> = 25°C unless otherwise noted.

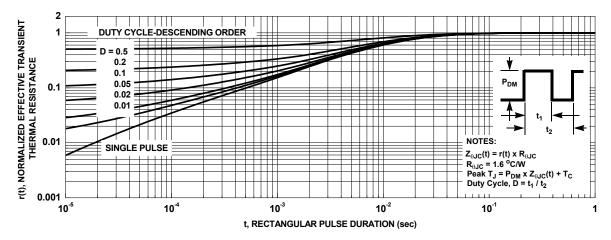


Figure 13. Junction-to-Case Transient Thermal Response Curve

#### Typical Characteristics (Q2 N-Channel) T<sub>J</sub> = 25 °C unless otherwise noted.

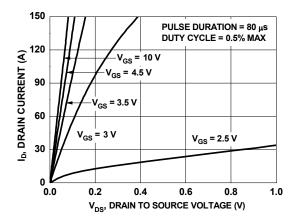


Figure 14. On- Region Characteristics

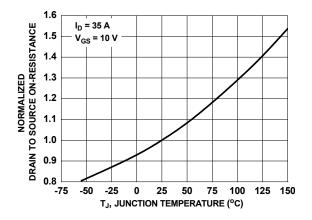


Figure 16. Normalized On-Resistance vs. Junction Temperature

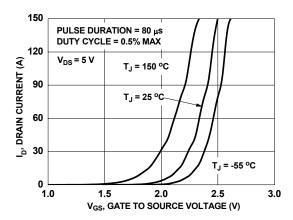


Figure 18. Transfer Characteristics

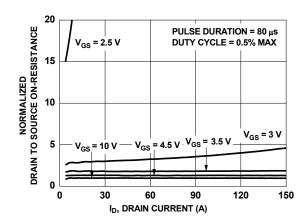


Figure 15. Normalized on-Resistance vs. Drain Current and Gate Voltage

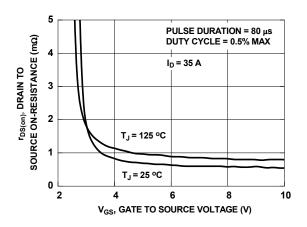


Figure 17. On-Resistance vs. Gate to Source Voltage

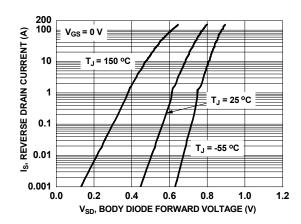


Figure 19. Source to Drain Diode Forward Voltage vs. Source Current

#### Typical Characteristics (Q2 N-Channel) T<sub>.I</sub> = 25°C unless otherwise noted.

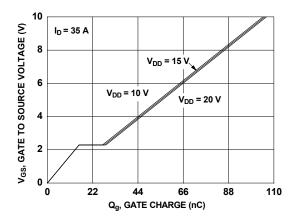


Figure 20. Gate Charge Characteristics

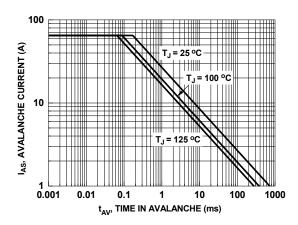


Figure 22. Unclamped Inductive Switching Capability

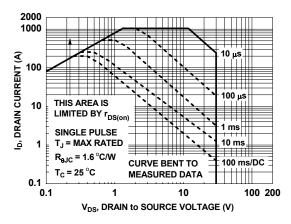


Figure 24. Forward Bias Safe Operating Area

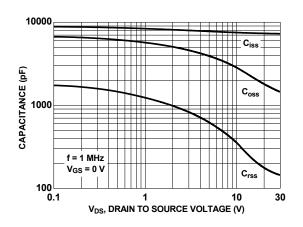


Figure 21. Capacitance vs. Drain to Source Voltage

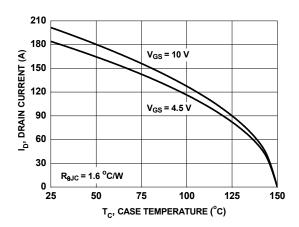


Figure 23. Maximum Continuous Drain Current vs. Case Temperature

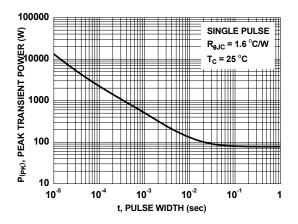


Figure 25. Single Pulse Maximum Power Dissipation

## Typical Characteristics (Q2 N-Channel) T<sub>J</sub> = 25 °C unless otherwise noted.

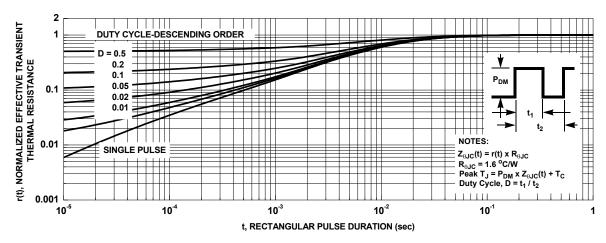
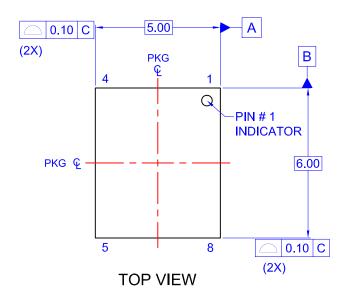
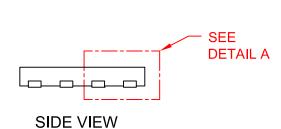
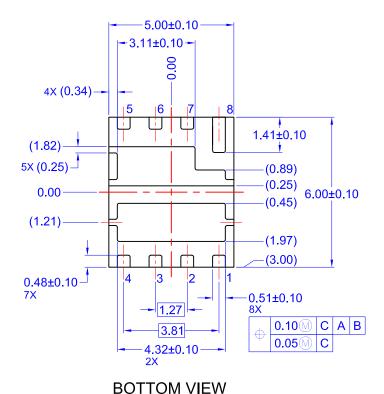
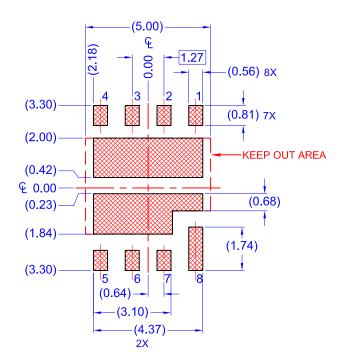


Figure 26. Junction-to-Case Transient Thermal Response Curve

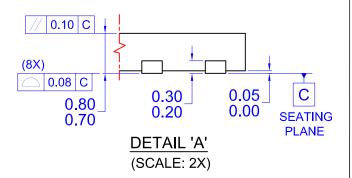








#### RECOMMENDED LAND PATTERN



NOTES: UNLESS OTHERWISE SPECIFIED

- A) PACKAGE STANDARD REFERENCE: JEDEC REGISTRATION, MO-240, VARIATION AA.
- B) ALL DIMENSIONS ARE IN MILLIMETERS.
- C) DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. MOLD FLASH OR BURRS DOES NOT EXCEED 0.10MM.
- D) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-2009.
- E) IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.
- F) DRAWING FILE NAME: MKT-PQFN08QREV2



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